Se	arch No	tes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/709,323	FAY ET AL.	
Examiner	Art Unit	-
Susanna M. Diaz	3694	

SEARCHED			
Class	Subclass	Date	Examiner
705	7	4/2/2007	SMD
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		')
	DATE	EXMR
East (see attached) Dialog (see attached) Internet (see attached)	3/12/2007	SMD
EIC Search (see attached)	3/22/2007	SMD
Consulted 10 Panel Members Bob Wanhara Henc Stamber — Re: 101	4 3/17/67	SMD
		